

# GSMDC6902X

## 60V N-Channel MOSFETs

### Product Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

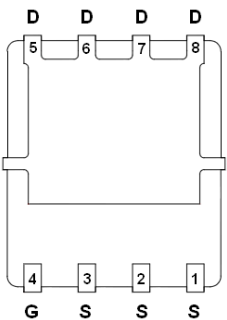
### Features

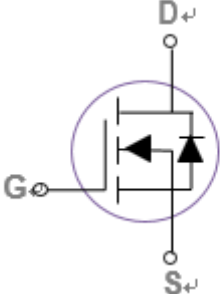
- 60V,100A,  $R_{DS(ON)} = 4.6m\Omega @ V_{GS} = 10V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

### Applications

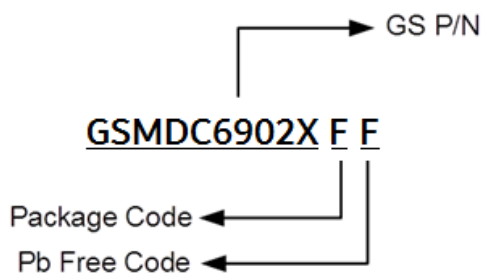
- Power Tools
- Load Switch
- LED applications
- Motor Drive Applications

### Packages & Pin Assignments

GSMDC6902XFF (DFN5X6-8L)	
 <p>Bottom View</p>	
Pin	Description
1	Source
2	Source
3	Source
4	Gate
5	Drain
6	Drain
7	Drain
8	Drain

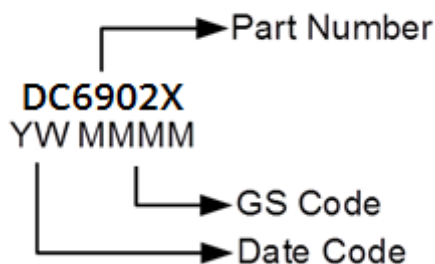


## Ordering Information



Part Number	Package
GSMDC6902XFF	DFN5X6-8L

## Marking Information



## Absolute Maximum Ratings

T<sub>c</sub>=25°C Unless otherwise noted

Symbol	Parameter	Typical	Unit
V <sub>DS</sub>	Drain-Source Voltage	60	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> =25°C	100
		T <sub>c</sub> =100°C	63
I <sub>DM</sub>	Pulsed Drain Current	400	A
EAS	Single Pulse Avalanche Energy	450	mJ
IAS	Single Pulse Avalanche Current	95	A
P <sub>D</sub>	Power Dissipation (T <sub>c</sub> =25°C)	142	W
	Power Dissipation (Derate above 25°C)	1.14	W/°C
T <sub>J</sub>	Operating Junction Temperature Range	-50 to +150	°C
T <sub>STG</sub>	Storage Temperature Range	-50 to +150	°C
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient	62	°C/W
R <sub>θJC</sub>	Thermal Resistance-Junction to Case	0.88	°C/W

## Electrical Characteristics

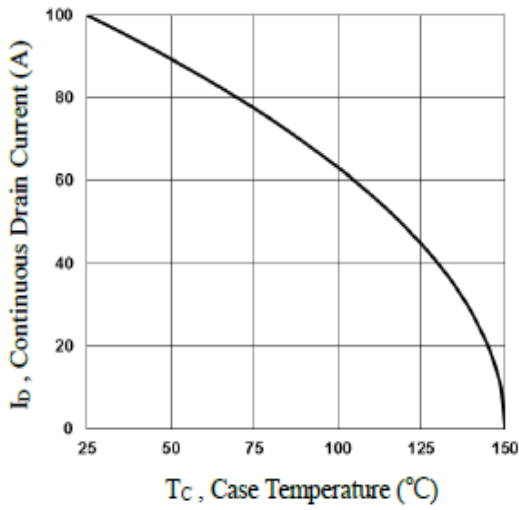
T<sub>j</sub>=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	60			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	1	1.6	2.5	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C			1	uA
		V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C			10	
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current			100	A
I <sub>SM</sub>	Pulsed Source Current				200	
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A		3.8	4.6	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A		4.2	5.5	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =3A		25		S
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C			1	V
<b>Dynamic</b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =30V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A		58.2	116	nC
Q <sub>gs</sub>	Gate-Source Charge			16.2	32	
Q <sub>gd</sub>	Gate-Drain Charge			23.4	46	
C <sub>iSS</sub>	Input Capacitance	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, F=1MHz		6805	10000	pF
C <sub>oss</sub>	Output Capacitance			445	680	
C <sub>rSS</sub>	Reverse Transfer Capacitance			195	280	
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =30V, I <sub>D</sub> =1A, V <sub>GS</sub> =10V, R <sub>G</sub> =6Ω		19.2	40	ns
t <sub>r</sub>				56.3	120	
t <sub>d(off)</sub>	Turn-Off Time			90.8	200	
t <sub>f</sub>				21.6	40	
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, F=1MHz		1.3	2.6	Ω

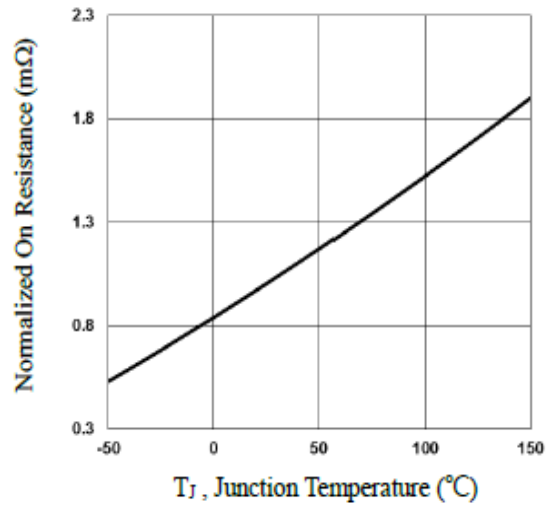
Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. V<sub>DD</sub>=25V, V<sub>GS</sub>=10V, L=0.1mH, I<sub>AS</sub>=95A., Starting T<sub>J</sub>=25°C
3. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
4. Essentially independent of operating temperature.

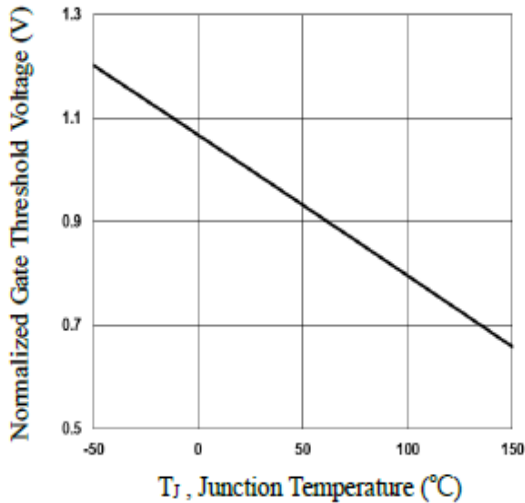
## Typical Performance Characteristics



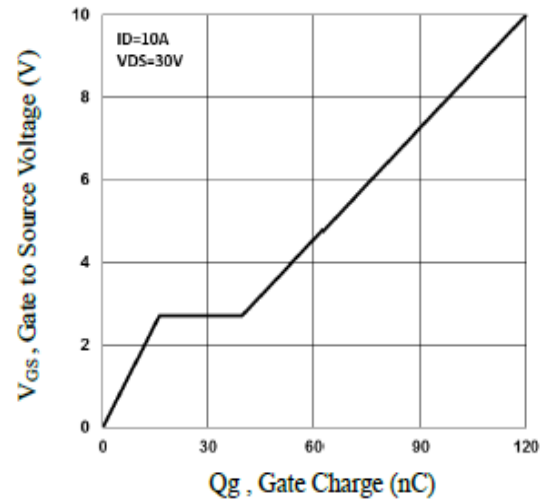
**Fig.1 Continuous Drain Current vs. Tc**



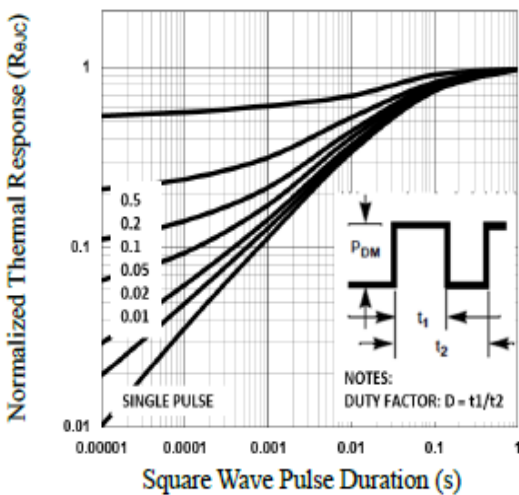
**Fig.2 Normalized RDS(on) vs. Tj**



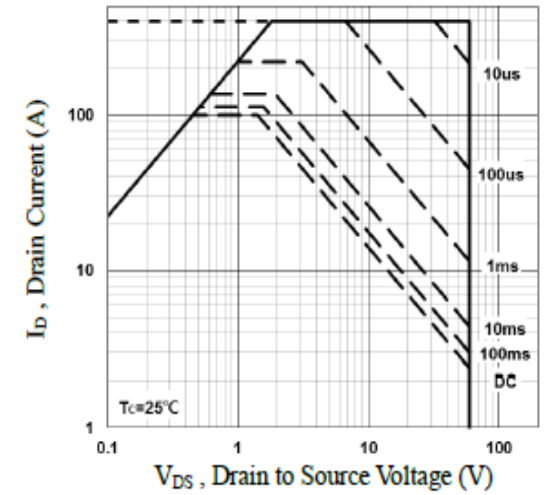
**Fig.3 Normalized Vth vs. Tj**



**Fig.4 Gate Charge Characteristics**



**Fig.5 Normalized Transient Impedance**



**Fig.6 Maximum Safe Operation Area**

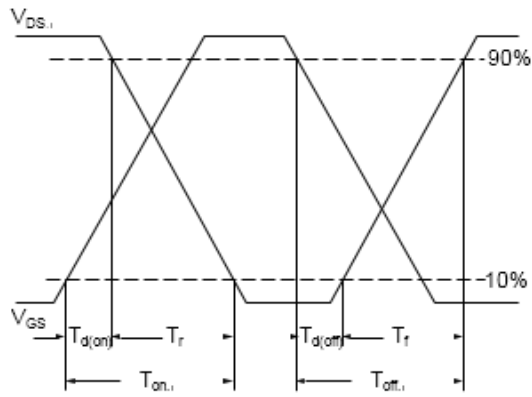


Fig.7 Switching Time Waveform

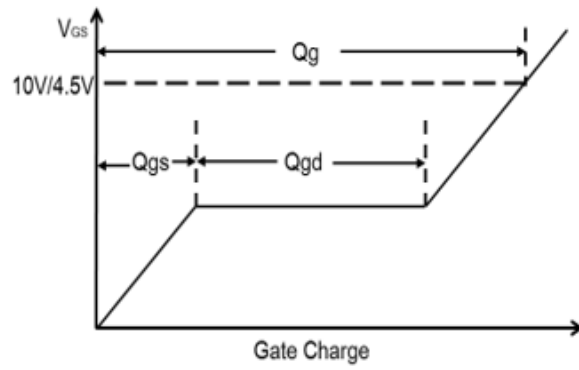
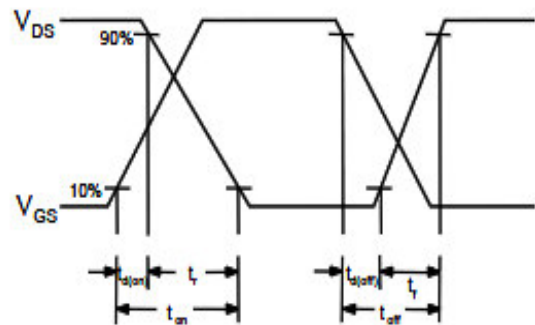
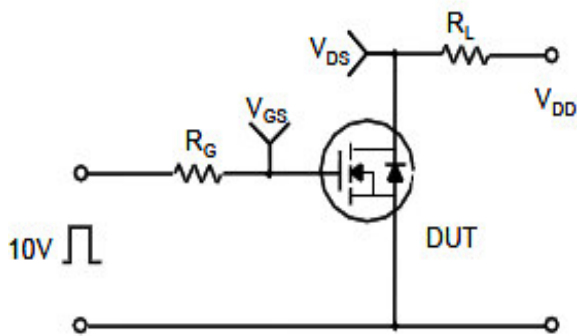


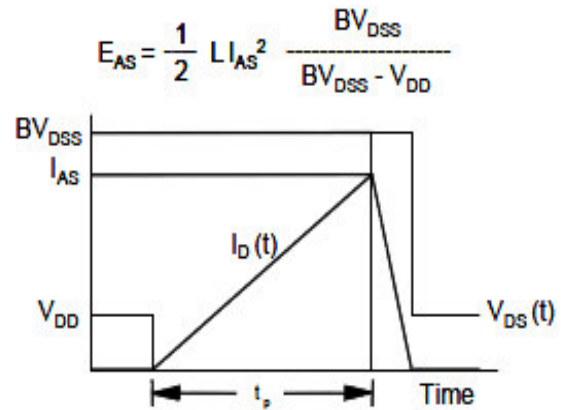
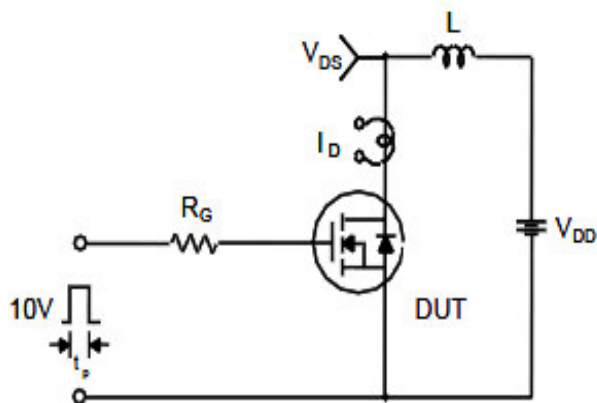
Fig.8 Gate Charge Waveform

Typical Performance Characteristics (Continue)

Resistive Switching Test Circuit & Waveforms



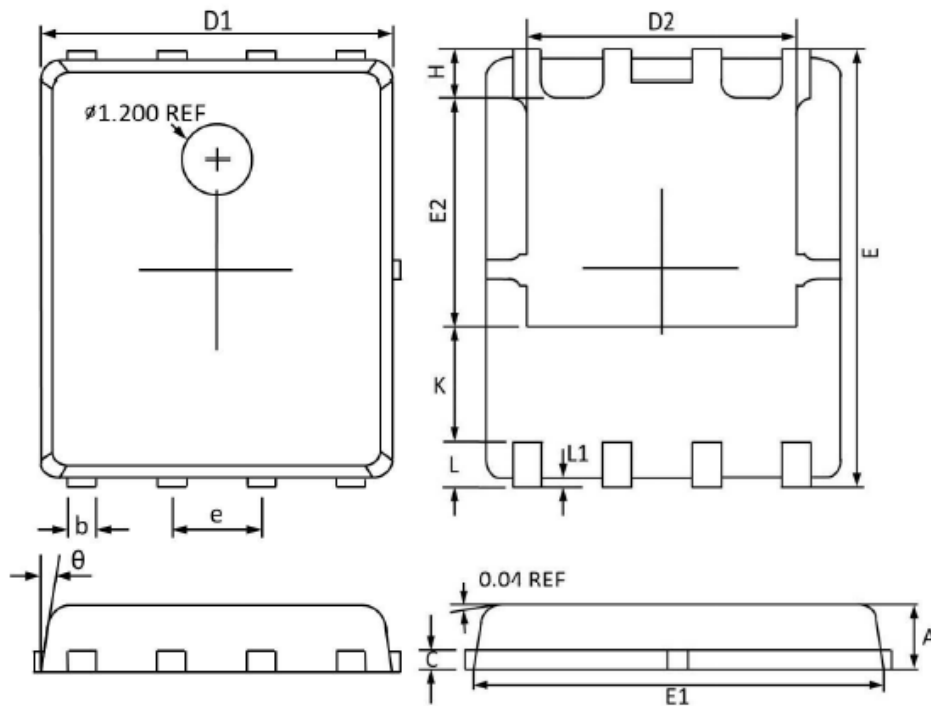
Unclamped Inductive Switching Test Circuit & Waveforms



## Package Dimension

# DFN5X6-8L

## PPAK5x6 PACKAGE INFORMATION









Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	1.100	0.800	0.043	0.031
b	0.510	0.330	0.020	0.013
C	0.300	0.200	0.012	0.008
D1	5.100	4.800	0.201	0.189
D2	4.100	3.610	0.161	0.142
E	6.200	5.900	0.244	0.232
E1	5.900	5.700	0.232	0.224
E2	3.780	3.350	0.149	0.132
e	1.27BSC		0.05BSC	
H	0.700	0.410	0.028	0.016
K	1.500	1.100	0.059	0.043
L	0.710	0.510	0.028	0.020
L1	0.200	0.060	0.008	0.002
$\theta$	12°	0°	12°	0°

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